Laser-induced ultrafast electron emission from a field emission tip

Brett E. Barwick
*University of Nebraska-Lincoln*, brett.barwick@trincoll.edu

C. Corder
*University of Nebraska - Lincoln*

James Strohaber
*University of Nebraska - Lincoln*, jstroha1@gmail.com

Nathan A. Chandler-Smith
*University of Nebraska - Lincoln*, nchandlersmith2@unl.edu

Cornelis J. Uiterwaal
*University of Nebraska - Lincoln*, cuiterwaal2@unl.edu

*See next page for additional authors*

Follow this and additional works at: [https://digitalcommons.unl.edu/physicsfacpub](https://digitalcommons.unl.edu/physicsfacpub)

Part of the [Physics Commons](https://digitalcommons.unl.edu/physicsfacpub)

Barwick, Brett E.; Corder, C.; Strohaber, James; Chandler-Smith, Nathan A.; Uiterwaal, Cornelis J.; and Batelaan, Herman, "Laser-induced ultrafast electron emission from a field emission tip" (2007). *Faculty Publications, Department of Physics and Astronomy*. 67. [https://digitalcommons.unl.edu/physicsfacpub/67](https://digitalcommons.unl.edu/physicsfacpub/67)

This Article is brought to you for free and open access by the Research Papers in Physics and Astronomy at DigitalCommons@University of Nebraska - Lincoln. It has been accepted for inclusion in Faculty Publications, Department of Physics and Astronomy by an authorized administrator of DigitalCommons@University of Nebraska - Lincoln.
Authors
Brett E. Barwick, C. Corder, James Strohaber, Nathan A. Chandler-Smith, Cornelis J. Uiterwaal, and Herman Batelaan
Laser-induced ultrafast electron emission from a field emission tip

B. Barwick, C. Corder, J. Strohaber, N. Chandler-Smith, C. Uiterwaal, and H. Batelaan

Department of Physics and Astronomy, University of Nebraska–Lincoln, 116 Brace Laboratory, PO Box 880111, Lincoln, Nebraska 68588-0111, USA

1 Corresponding author; email: hbatelaan2@unl.edu

Abstract. We show that a field emission tip electron source that is triggered with a femtosecond laser pulse can generate electron pulses shorter than the laser pulse duration (100 fs). The emission process is sensitive to a power law of the laser intensity, which supports an emission mechanism based on multiphoton absorption followed by over-the-barrier emission. Observed continuous transitions between power laws of different orders are indicative of field emission processes. We show that the source can also be operated so that thermionic emission processes become significant. Understanding these different emission processes is relevant for the production of sub-cycle electron pulses.

The temporal resolution of ultrafast electron diffraction (UED)\cite{1, 2}, ultrafast electron microscopy (UEM)\cite{2}–[4] and ultrafast electron crystallography (UEC)\cite{2} is limited to the duration of the electron pulse. The ultrafast electron source most commonly used in these applications is based on electron emission induced by focusing an amplified femtosecond laser pulse on to a surface \cite{1, 5}. Due to the high particle density per pulse, space-charge broadens the pulse duration to 500 fs \cite{5}. An interesting electron source implementing a Ti:sapphire oscillator has been used to generate 27 fs electron pulses \cite{6} using impulsively excited surface plasmons. However, this method has a large kinetic energy spread ($\Delta E \sim 100$ eV) in the emitted electrons, which would cause the pulse to expand temporally as it propagates. An electron gun has been proposed that could produce sub-fs electron pulses \cite{7}. This 10 keV source would have an initial energy spread of $\Delta E \sim 1$ eV, but this spread would be reduced by injecting the electrons into an RF cav-
ity to compensate for the different velocities, allowing the electron packet to arrive at a target in a sub-fs time window. A promising and experimentally realized source relies on the combination of a field emission tip with a low power femtosecond oscillator [8]–[10]. The low laser powers required allow the production of few electrons per pulse with high repetition rates. This gives useful average electron count rates and overcomes space-charge broadening. Field emission tip sources also have small energy spreads ($\Delta E < 1 \text{ eV}$) [11, 12], so their temporal expansion is suppressed. Assuming that the emission process from the nanometer tip is due to optical field emission, the electron bunches were claimed to be sub-cycle [9].

In this paper, we study the emission of electrons from a nanometer tip due to femtosecond laser pulses. Our pump–probe data shows that the laser-induced electron pulses are shorter than 100 fs justifying the claim of Hommelhoff et al [9] and Ropers et al [10]. It is important to note that a (nonlinear) autocorrelation spectrum such as that shown by Ropers et al (their figure 2(a)) and Hommelhoff et al (their figure 2(a)) does not provide any information on the electron pulse duration. The pulse duration can be determined by the absence or presence of the additive nature of the electron emission process (as Hommelhoff et al [9] points out but does not show data). A detailed discussion of the autocorrelation spectrum and its additive nature will be given below.

The next important question is: “How much shorter than 100 fs is the electron pulse duration?” No direct measurement of the electron pulse duration is available to date. However, identifying the emission mechanism can help predict the pulse duration, and assist in operating the source in an experimental parameter range where shorter electron pulses could be obtained. In this context, it is highly interesting that the mechanisms suggested in [9] and [10] are not identical. Hommelhoff et al [9] claim a pure optical tunneling mechanism. Ropers et al [10] consider a multiphoton mechanism and also an optical tunneling mechanism from an adjustable nonequilibrium carrier distribution in the metal tip [10]. This suggests that the agreement in [9] with data could be fortuitous, given the alternative emission mechanisms in [10].

We investigated the emission process by considering thermionic emission [13], optical field emission [9] and multiphoton emission [10]. Multiphoton absorption can be followed by electron emission over a barrier lowered by the Schottky effect [14]. Optical field emission is based on the instantaneous laser electric field lowering the potential barrier, thus allowing electrons to tunnel out of the tip. An analysis of our experimental data shows characteristics of both mechanisms. This is in accordance with the value of our Keldysh parameter [6, 15, 16]. The nature of the emission process is not uniquely established and depends critically on the experimental parameters. This stimulates further debate on the detailed emission process and its consequence for the ultimate electron pulse duration for this source. Only direct experimental evidence, such as diffraction in time experiments [17]–[19], would unambiguously support the claim that the electron emission is sub-cycle.

To help determine the nature of the emission process we study two mechanisms in detail (figure 1). The optical field emission process is electron-tunneling through a barrier $V$ that has been lowered by $F_{\text{tot}}$, the sum of a dc and laser field. Tunneling is most likely for electrons close to the Fermi level, $E_F$. Multiphoton absorption can lead to over-the-barrier emission. Upon absorption of four or more photons the gained electron energy exceeds the workfunction $\phi$ and direct emission can occur. Here we do not distinguish between coherent and incoherent multiphoton absorption [6]. An applied DC field reduces the workfunction to $\phi_{\text{eff}}$ (Schottky effect [20]) thus lowering the number of photons required for over-the-barrier emission. We also consider the possibility of photon absorption followed by tunneling. These models do not include any band structure [14],
Laser-induced ultrafast electron emission from a field emission tip

Collision dynamics in the tip [21], or dynamic polarizability in the tip [22]–[26], and cannot be expected to describe the detailed dynamics of the emission process. However, our simple models agree well with experiment. We now turn our attention to a more detailed description of the model.

For \( n \)-photon absorption the electron emission rate \( J_{\text{abs},n} \) is proportional to the \((2n)\)th power of the laser field (\( \theta \) is the angle between the laser field polarization and the tip axis),

\[
J_{\text{abs},n} (F_{\text{laser}}) \propto (F_{\text{laser}} \cos \theta)^{2n},
\]

where the energy of the excited electron must exceed the effective potential barrier, \( n\hbar \omega > \phi_{\text{eff}} \).

The Schottky effect is given by \( \phi_{\text{eff}} = \phi - e[F_{\text{dc}}/(4\pi\varepsilon_0)]^{1/2} \) [20]. Above-threshold photoemission \((n \geq 5)\) could contribute to the total electron emission signal [27], we also ignore thermalization effects due to electron–electron interactions.

The polarization (\( \theta \)) dependence of the electron emission can be attributed to an increased probability of photon absorption when the electric field is perpendicular to a surface (parallel to the tip axis) [28]. Other groups have attributed the polarization dependence to the motion of the conduction electrons in the metal tip [23]–[26]. This lightning effect treatment causes an enhancement of the field near the tip because the optical field could make conduction electrons bunch at the tip apex. There is considerable disagreement in both theoretical and experimental papers.

Figure 1. Electron emission mechanisms. Optical field emission is depicted with the green arrow and multiphoton absorption followed by over-the-barrier emission is depicted with the red arrow. If an electron at the Fermi energy, \( E_F \), absorbs multiple photons it can gain enough energy to exceed the potential well. The height of the effective potential barrier \( \phi_{\text{eff}} \) is determined by the workfunction of the metal \( \phi \) and the applied dc field (Schottky effect [20]). Photoexcitation may precede tunneling (for a detailed description see text).
[23]–[26] to the amount of enhancement, but, fortunately, the lightning effect does not affect the power law behavior and is therefore not explicitly given in equation (1).

In our pump–probe experiments, the temporal dependence of the laser field is given by

\[ F_{\text{laser}}(t) = F_{01} \exp(-at^2) \cos(bt^2 + \omega t) + F_{02} \exp(-a(t + x_0/c)^2) \cos\left(b(t + x_0/c)^2 + \omega(t + x_0/c)\right), \]

(2)

where \(a\) and \(b\) are the complex beam parameters [29]. This laser field is the superposition of two pulses, separated in time by a relative delay of \(x_0/c\) which we introduce using an autocorrelator. We determine the magnitudes \(F_{0i}\) of each of the two pulses separately by measuring their average laser power \(P_{\text{avg}}\):

\[ F_{0i} = \sqrt{\frac{16 P_{\text{avg},i}}{f_{\text{rep}} d^2 t_{\text{laser}} c_0 (\pi/2)^{3/2}}} \approx 25 \sqrt{\frac{P_{\text{avg},i}}{f_{\text{rep}} d^2 t_{\text{laser}}}}, \]

(3)

in which \(f_{\text{rep}}\) is the repetition rate of the laser, \(d\) the full-width-half-maximum of the focal spot, and \(t_{\text{laser}}\) the laser pulse duration. We find the emission current as a function of the autocorrelator delay \(x_0/c\) by numerical integration over time. Equation (1) directly gives the electron emission as a function of polarization and laser power.

If the laser field causes electrons to tunnel, the current from the tip, \(J_{\text{field}}\), is given by the Fowler–Nordheim equation,

\[ J_{\text{field}}(F_{\text{tot}}) \propto a_n \frac{F_{\text{tot}}^2}{(\phi - n\hbar \omega)} \exp\left(-C_0 (\phi - n\hbar \omega)^{3/2}/F_{\text{tot}}\right), \]

(4)

for a constant \(C_0\) [30], and the excited state populations are assumed to be proportional to a power of the laser intensity, \(a_n \propto P^n\). The total electric field is the sum of the static and laser fields: \(F_{\text{tot}} = F_{\text{dc}} + F_{\text{laser}} \ell \cos \theta\). The factor \(\ell\) accounts for the field enhancement due to the lightning effect. The static electric field is given by \(F_{\text{dc}} = V/kr\), where \(V\) is the voltage placed on the tip, \(r\) is the tip radius, and \(k\) (here equal to 5) accounts for details in the tip geometry [31]. To describe tunneling preceded by absorption of \(n\) photons we lower the workfunction to \(\phi - n\hbar \omega\). We find the emission current by numerical integration over time.

Such time averaging is only appropriate if the tunneling time of the electron from the metal tip [16] is shorter than the optical period of the laser light. In the field of an electromagnetic wave, the critical parameter identifying this regime is the Keldysh parameter \(\gamma\). For \(\gamma \gg 1\) multiphoton absorption dominates, while tunneling dominates for \(\gamma \ll 1\) [15, 16]. For a metal surface the Keldysh parameter is given by \(\gamma = \omega(2m\phi)^{3/2}/(eF_{\text{laser}})\) [6]. For a field emission tip the magnitudes of the DC field and laser field are of the same order and the emission process is strongly dependent on both fields. The Keldysh parameter should thus depend not only on \(F_{\text{laser}}\) but also on \(F_{\text{dc}}\). This dependence is present when the workfunction is replaced with the effective workfunction. Note that the Keldysh parameter is only meaningful when the photon energy is less than the workfunction.

We also consider the possibility of laser induced thermionic emission. It has been suggested that thermionic emission is most efficient when the laser polarization is perpendicular to the tip axis [13]. On the other hand, in the investigated experimental regime thermionic emission is thought to be negligible [13, 22, 30].
A schematic of our experimental set-up appears in figure 2. Laser pulses from a Ti:sapphire femtosecond oscillator (Spectra Physics Tsunami) are first compressed using a single-prism pulse compressor [32]. A subsequent variable attenuator controls the delivered laser power. We use a Mach–Zehnder type autocorrelator to split the laser pulse into a pump and probe pulse and to provide a variable time delay between them. We let the recombined laser beam emanating from the autocorrelator pass through a half-wave plate to adjust the overall laser polarization. A frequency resolved optical gate (FROG) is used to measure the pulse characteristics just before the pulse enters the vacuum system. We measure a laser pulse width of 32 fs, with a time-bandwidth product of 0.5. The fused silica vacuum entrance window is 3 mm thick. To focus the laser beam on to the field emission tip we use a 90° off-axis gold-coated parabolic mirror placed in the vacuum system (parent focal length = 12.7 mm, P/N A8037-176 Janos Technology). Alternatively, an achromatic lens or on-axis spherical mirror could be used to achieve a similar quality focus. We have connected the field emission tip to an XYZ translation stage through a flexible bellows to allow for optimization of the electron emission. The tungsten tip is etched with a lamella drop-off method [33].

The experiment is contained in an aluminum vacuum chamber that is evacuated with a turbo-molecular pump and is operated at a pressure of $\sim 10^{-8}$ Torr. To estimate the tip radius the Fowler–Nordheim equation is fit [31] to the voltage-dependent electron emission yield, giving a value of 40 nm. A metal plate with a 5-mm pinhole placed at 1 cm from the tip defines the ground potential. A channeltron (Sjuts KBL 520) is used to detect the electrons. Once the laser pulses have left the vacuum system through a second optical window we measure the average beam power with a power meter. The electron pulse detection signals are sent through a constant fraction discriminating amplifier, and then fed into a multichannel scaling board. This board records electron
counts as the autocorrelator is scanned and in this way acquires an electron emission autocorrelation spectrum. The laser intensity autocorrelation trace (figure 3(a)) is measured simultaneously with the electron emission autocorrelation spectrum (figure 3(b)). In this way the laser intensity can be correlated to the electron emission. The oscillator delivers pulses at a repetition rate of 75 MHz, with a maximum average output power of 500 mW corresponding to a pulse energy of 10 nJ. This is enough to damage the tip so a variable attenuator is used. To avoid detector damage we limit the electron count rate to $10^6$ s$^{-1}$ (reached at 25 mW depending on the applied dc voltage). We estimate the laser focus to have a full width at half maximum of 4 μm.

When the two pulses emanating from the autocorrelator are delayed to the extent that they do not overlap, they act as a pump–probe pair. The first pulse influences the tip and the second pulse probes if the tip “remembers” the first pulse. Once the electron emission from the two laser pulses becomes additive, there is no memory of the first pulse anymore, so the electron emission process should be at least as fast as the delay for which this happens (figure 3(c)). The temporal resolution of this pump–probe experiment is limited to the duration of the laser pulse, because the two pulses are coherent with each other. As the delay between them is reduced below their temporal width, the two laser pulses start to interfere, creating an intensity modulation which is seen in the autocorrelation trace (figure 3(a)).

At delays greater than 100 fs the sum of the electron signals with each laser pulse separately (blue and red), nearly equals the electron signal with both pulses present (black). As discussed above, this additive behavior indicates that the electron emission process is faster than 100 fs. In a very recent similar study [9] this additive behavior is also reported at 100 fs.
A pulse duration of 100 fs is compatible with the mechanisms we consider. However, the temporal behavior of thermalization (or more general, electron–electron interactions) in a field emission tip is unknown [13, 22, 30]. For a field emission model one expects that the electron emission process is of sub-cycle duration [9]. The time for multiphoton over-the-barrier emission for a tip is unknown to the authors and will depend on the detailed electron dynamics.

In an attempt to identify the physical process(es), the laser intensity dependence of the emission yield is measured. The experimental data are shown in figure 4(a) on a log–log scale. Our data cannot be fit well to a pure optical tunneling model from the Fermi level (OF); this contrasts with the interpretation given in [8]. To investigate the $n$-photon absorption model in detail (equa-
tion (1), we fit our data to $\Sigma_{n=0,5} c_n I^n$. The data labeled with "$n = 4$" in figure 4(a) are dominated by the fourth order power law, consistent with a very recent observation [10]. The data labeled with "$n = 3$" in figure 4(a) have significant contributions from the second, third and fourth order (figure 4(b)). Varying the dc-field shows that contributions from more than one order is typical. As a result, a single power fit to the electron yield shows that integer powers are uncommon (figure 4(c)) and the "$n = 4$" fit quality may be fortuitous. Optical field emission described by equation (4) including excited states can also appear as a straight line (see dashed line (FN) in figure 4(a)). All these observations render an identification of the specific process difficult.

For our experiment, the observed $I^4$ dependence may be due to two different mechanisms. The first mechanism is absorption of four 810 nm photons with a combined energy of 6.0 eV, which equals or exceeds the value of all known workfunctions for tungsten (between 4.3 and 6.0 eV) [34]. A second explanation could be that three photons are sufficient to cause over-the-barrier emission, with a fourth photon being absorbed in above-threshold photoemission [14, 27]. However, optical field tunneling may also contribute significantly to the electron emission.

Our estimated Keldysh parameter is consistent with our observations. For an average laser power of 40 mW (the highest power in figure 4(a)) and an FWHM pulse duration of 50 fs, the optical field is 0.6 GV m$^{-1}$. This field is nearly equal to that used in [6] and [8]. For the range of DC fields used, the Keldysh parameter is between 3 and 4. The photon energy is less than the effective workfunction which justifies the Keldysh approach.

Finally, a polarization dependent measurement can reveal the presence of laser induced thermionic emission. As mentioned above, thermionic emission is thought to be most efficient when the laser polarization is perpendicular to the tip axis [13]. A half wave plate is used to rotate the laser polarization (figure 5). In figure 5(a) the electron emission is negligible for polarization per-

Figure 5. Polarization dependent electron yield. Panel (a) shows the electron signal as a function of laser polarization angle for careful alignment. A maximum yield is observed when the laser polarization is parallel to the tip, and the minima correspond to laser polarizations perpendicular to the tip. These data are taken for the same experimental conditions as the "$n = 3$" data in figure 4(a). Panel (b) shows a typical measurement with a less careful alignment which leads to a secondary peak for perpendicular polarization. The black lines are guides to the eye.
perpendicular to the tip. This is achieved by carefully aligning the apex of the tip to coincide with the centre of the laser focus, which is the chosen configuration for all the data taken above. However, when the tip is moved slightly deeper into the focal region a secondary peak appears for perpendicular polarization (figure 5(b)). Note that this does not exclude fast thermalization at polarizations parallel to the tip.

In conclusion, the additive nature of the pump–probe experiment is strong evidence that the electron emission process is prompt to the 100 fs level in agreement with Hommelhoff et al [9] and Ropers et al [10]. Sub-100 fs resolution is promising for UEM and diffraction. One of the factors limiting the currently achieved resolution to about 1 ps is space charge broadening [5], which is absent for this electron source. Electrons from a 40 nm tip source can be focused for ultrafast microscopy and collimated for ultrafast diffraction.

Our experimental data show characteristics of multiple emission processes. Experimental parameters may be chosen to favor a particular process. This opens perspectives to optimize this type of source to attain the shortest possible electron pulses duration. Diffraction-in-time methods may offer the possibility to monitor the optimization process down to the attosecond domain.

Acknowledgment
This material is based upon study supported by the National Science Foundation under grant no. 0354940 and grant no. 0355235.

References
[29] Siegman A E 1986 Lasers (Sausalito: University Science Books)
[34] Müller E W 1955 J. Appl. Phys. 26 732